

Search Notes

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10/079,767

Examiner

Than Nguyen

Applicant(s)/Patent under
Reexamination

GRAF ET AL.

Art Unit

2187

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST IEEE Inventor	7/27/2007	NTV